DATA SHEET

MOS FIELD EFFECT TRANSISTOR

[/]NP88N055CHE, NP88N055DHE, NP88N055EHE

SWITCHING N-CHANNEL POWER MOS FET INDUSTRIAL USE

DESCRIPTION

These products are N-channel MOS Field Effect Transistor designed for high current switching applications.

FEATURES

- Channel temperature 175 degree rated
- Super low on-state resistance $R_{DS(on)} = 5.3 \text{ m}\Omega \text{ MAX.} (V_{GS} = 10 \text{ V}, \text{ ID} = 44 \text{ A})$
- Low Ciss : Ciss = 7600 pF TYP.
- Built-in gate protection diode

ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage	Vdss	55	V
Gate to Source Voltage	Vgss	±20	V
Drain Current (DC) Note1	D(DC)	±88	А
Drain Current (Pulse) Note2	D(pulse)	±352	А
Total Power Dissipation (T _A = 25°C)	P⊤	1.8	W
Total Power Dissipation (Tc = 25°C)	Ρτ	288	W
Single Avalanche Current Note3	las	65 / 88	А
Single Avalanche Energy Note3	Eas	422 / 15	mJ
Channel Temperature	Tch	175	°C
Storage Temperature	Tstg	-55 to +175	°C

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- **Notes 1.** Calculated constant current according to MAX. allowable channel temperature.
 - **2.** PW \leq 10 μ s, Duty cycle \leq 1 %

3. Starting T_ch = 25 °C, R_G = 25 Ω , V_Gs = 20 V \rightarrow 0 V (See Figure 4.)

THERMAL RESISTANCE

Channel to Case	Rth(ch-C)	0.52	°C/W
Channel to Ambient	Rth(ch-A)	83.3	°C/W

ORDERING INFORMATION

PART NUMBER	PACKAGE	
NP88N055CHE	5CHE TO-220AB	
NP88N055DHE	TO-262	
NP88N055EHE	TO-263	



(TO-220AB)

(TO-262)







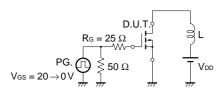
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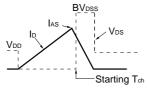
The mark \star shows major revised points.

ELECTRICAL CHARACTERISTICS (TA = 25°C)							
CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT	
Drain to Source On-state Resistance	RDS(on)	Vgs = 10 V, Id = 44 A		4.2	5.3	mΩ	
Gate to Source Threshold Voltage	VGS(th)	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	2.0	3.0	4.0	V	
Forward Transfer Admittance	y _{fs}	Vds = 10 V, Id = 44 A	30	60		S	
Drain Leakage Current	IDSS	Vds = 55 V, Vgs = 0 V			10	μA	
Gate to Source Leakage Current	lgss	$V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±10	μA	
Input Capacitance	Ciss	V _{DS} = 25 V		7600	11400	pF	
Output Capacitance	Coss	V _G s = 0 V		1100	1700	pF	
Reverse Transfer Capacitance	Crss	f = 1 MHz		480	870	pF	
Turn-on Delay Time	td(on)	ID = 44 A		42	93	ns	
Rise Time	tr	$V_{GS(on)} = 10 V$		26	66	ns	
Turn-off Delay Time	$t_{d(off)}$	$V_{DD} = 28 V$		120	240	ns	
Fall Time	tr	$R_G = 1 \Omega$		32	81	ns	
Total Gate Charge	Q _G	ID = 88 A		130	200	nC	
Gate to Source Charge	QGS	$V_{DD} = 44 V$		31		nC	
Gate to Drain Charge	Qgd	Vgs = 10 V		49		nC	
Body Diode Forward Voltage	VF(S-D)	IF = 88 A, VGS = 0 V		1.0		V	
Reverse Recovery Time	trr	IF = 88 A, VGS = 0 V		62		ns	
Reverse Recovery Charge	Qrr	di/dt = 100 A/µs		120		nC	

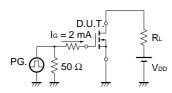
ELECTRICAL CHARACTERISTICS (TA = 25°C)

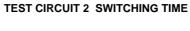
TEST CIRCUIT 1 AVALANCHE CAPABILITY

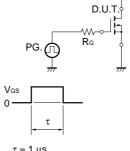




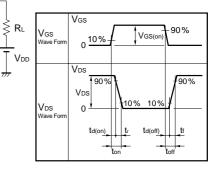
TEST CIRCUIT 3 GATE CHARGE



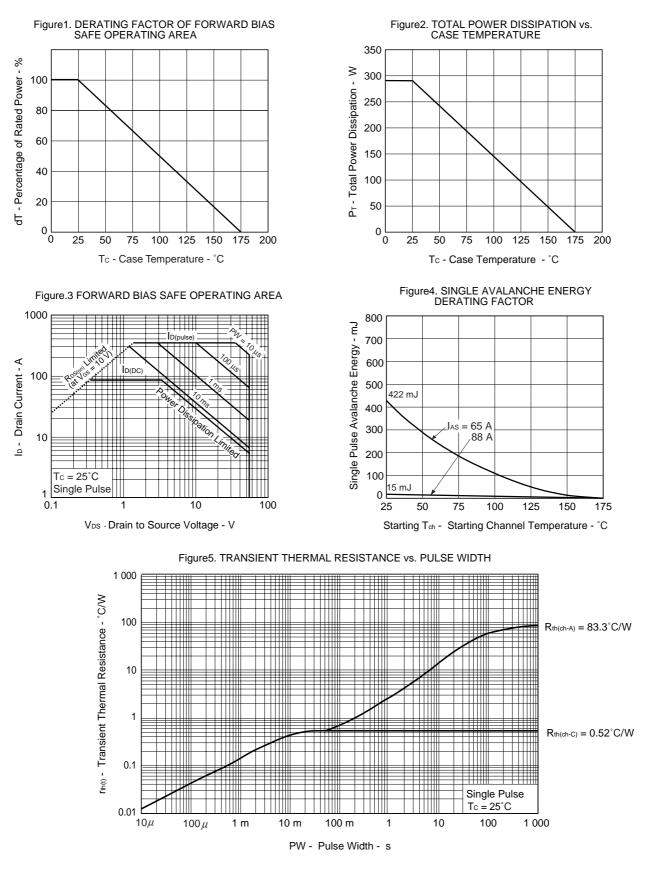




 $\begin{array}{l} \tau = 1 \; \mu s \\ \text{Duty Cycle} \leq 1 \; \% \end{array}$

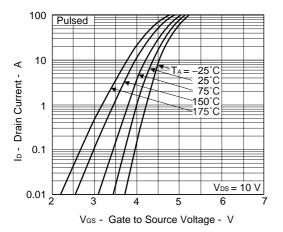


TYPICAL CHARACTERISTICS ($T_A = 25^{\circ}C$)

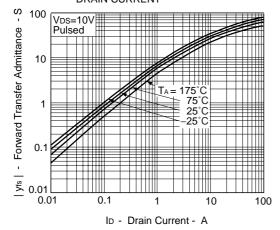


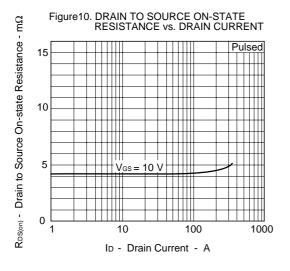
Data Sheet D14148EJ4V0DS00

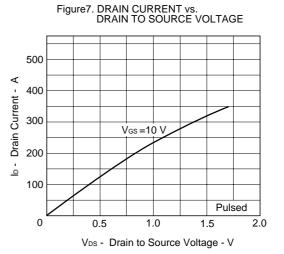
Figure6. FORWARD TRANSFER CHARACTERISTICS

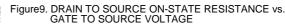


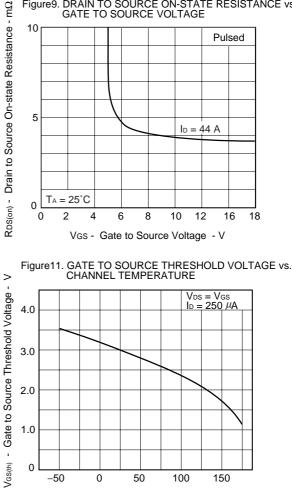






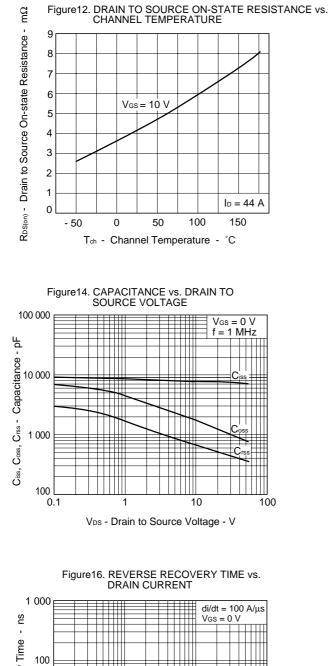






-50 0 50 100 150 Tch - Channel Temperature - °C

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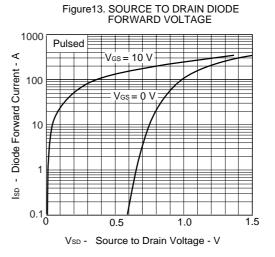


Figure 15. SWITCHING CHARACTERISTICS

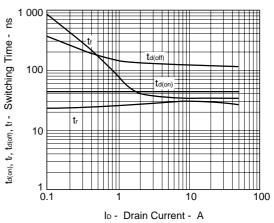
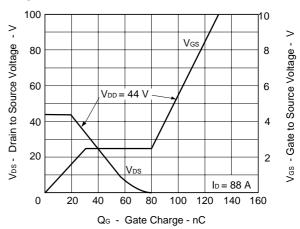


Figure17. DYNAMIC INPUT/OUTPUT CHARACTERISTICS



DRAIN CURRENT

I_F - Drain Current - A

10

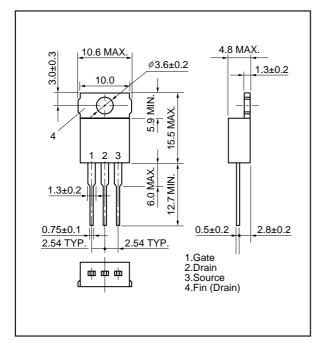
100

1.0

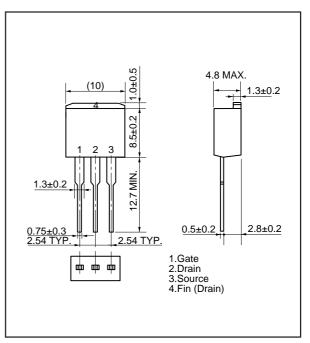
0.1

PACKAGE DRAWINGS (Unit: mm)

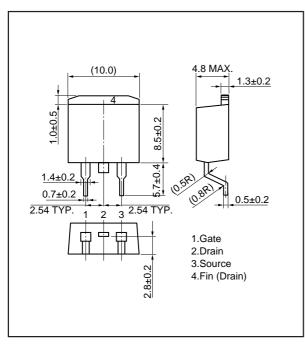
1) TO-220AB (MP-25)



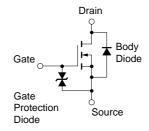
2) TO-262 (MP-25 Fin Cut)



3) TO-263 (MP-25ZJ)



EQUIVALENT CIRCUIT



Remark The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device. [MEMO]

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